Search Notes			

Application/Control No.	Applicant(s)/Patent Reexamination	under
10/788,588	OLIAEI, OMID	
Examiner	Art Unit	
Linh V. Nguyen	2819	

SEARCHED			
Class	Subclass	Date	Examiner
341	143,155	2/1/2006	LN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH N (INCLUDING SEAR	NOTES CH STRATEGY)	
	DATE EX	ИR
East search- see-printout	2/1/2006 LF	١